

The support of the test strip is composed of a transparent material and/or has cut-outs in the region of the test fields of the same or different shape through which the underside of the detection layers can be inspected. It is advantageous especially for an automation of the test evaluation when the support of the test strip has adjustment marks in the form of additional holes, cut-outs or notches.

## Brief Description of the Drawings

Figures 1 to 6 serve to illustrate the above-mentioned and the following description.

Figure 1 shows a perspective top-view, figure 2 shows a section along the cut line A-A', figure 3 shows a top-view of the underside of an embodiment of a test strip according to the invention.

Figure 4 shows a perspective top-view, figure 5 shows a section along the cut line A-A', figure 6 shows a top-view of the underside of an embodiment of a test strip according to the invention in which the spreading overlay according to the invention is composed of two overlay elements which are attached to the test strip in a preferred manner.

The reference numerals used in the figures have the following meaning:

- |           |                                    |
|-----------|------------------------------------|
| 1:        | test strip                         |
| 2:        | flexible carrier                   |
| 3 and 3a: | detection layers                   |
| 4 and 4a: | spacers                            |
| 5 and 5a: | adhesion layers                    |
| 6:        | overlay according to the invention |

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